


<b>Search Notes</b>  	<b>Application/Control No.</b>  10585067	<b>Applicant(s)/Patent Under Reexamination</b>  TANAKA ET AL.
	<b>Examiner</b>  NICOLE M BUIE	<b>Art Unit</b>  1796

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
524	495	5/21/2009	NMB

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor name search, PALM	5/21/2009	NMB
Reviewed related appln in eDAN 12/264089, 12/235021, 12/094775, 12/063331, 11/124262, 11/082479, 11/892729, 10/553976, 10/572779 (double patenting)	5/21/2009	NMB
EAST text search, see search history	5/21/2009	NMB

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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